

M62358P,FP**8-BIT 12CH D-A CONVERTER WITH BUFFER AMPLIFIERS****EXPLANATION OF TERMINALS**

Pin No.	Symbol	Function
③	DI	Serial data input terminal
⑳	DO	Serial data output terminal
②	CLK	Serial clock input terminal
①	LD	LD terminal input high level than latch circuit data load *1
⑳	V _{DD}	Digital power supply terminal
⑬	V _{CC}	Analog power supply terminal
⑩	GND	Digital and Analog common GND
⑫	V _{refU}	D-A converter high level reference voltage input terminal
⑪	V _{refL}	D-A converter low level reference voltage input terminal
⑳	\bar{R}	Reset terminal
⑭	Ao1	8-bit D-A converter output terminal
⑮	Ao2	
⑯	Ao3	
⑰	Ao4	
⑱	Ao5	
⑲	Ao6	
④	Ao7	
⑤	Ao8	
⑥	Ao9	
⑦	Ao10	
⑧	Ao11	
⑨	Ao12	

*1 When the LD terminal is "H" input data has load.

ABSOLUTE MAXIMUM RATINGS(T_a=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Ratings	Unit
V _{CC}	Supply voltage		-0.3~13.5	V
V _{DD}	Supply voltage		-0.3~7	V
V _{refU}	D-A converter high level reference voltage		V _{DD}	V
V _{IN}	Input voltage		-0.3~V _{DD} +0.3	V
I _{DO}	Output current		-5~+5	mA
I _{AO}	Buffer amplifier output current range		-5~+5	mA
T _{opr}	Operating temperature		-20~+85	°C
T _{stg}	Storage temperature		-40~+125	°C

RECOMMENDED OPERATING CONDITIONS

- Digital supply voltage V_{DD} 5V±10%
- Analog supply voltage V_{CC} V_{DD}-13V

ELECTRICAL CHARACTERISTICS

Digital part(V_{CC}=13V, V_{DD}=V_{refU}=5V, T_a=25°C, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
V _{DD}	Supply voltage		4.5		5.5	V
I _{DD}	Circuit current	CLK=1MHz in action			1	mA
V _{IL}	Input low voltage				0.2V _{DD}	V
V _{IH}	Input high voltage		0.8V _{DD}			V
V _{OL}	Output low voltage	I _{OL} =1.0mA			0.4	V
V _{OH}	Output high voltage	I _{OH} =-400μA	V _{DD} -0.4			V

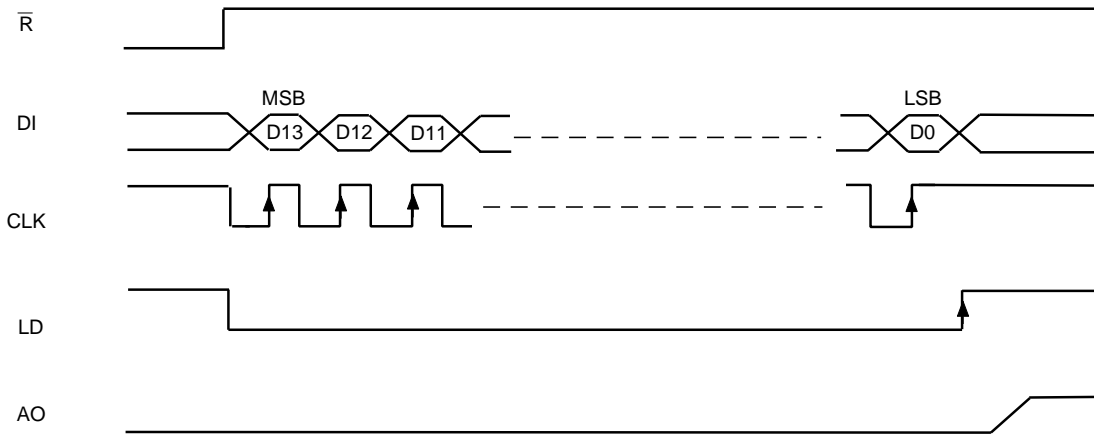
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8-BIT 12CH D-A CONVERTER WITH BUFFER AMPLIFIERS

Analog part ($V_{CC}=13V, V_{DD}=V_{refU}=5V, T_a=-20^{\circ}C \sim +85^{\circ}C$, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
V_{CC}	Supply voltage		V_{DD}		13	V
I_{CC}	Circuit current			3	6	mA
I_{refU}	D-A converter high level reference input current	All ch's set up at 107/256		2	4	mA
V_{refU}	D-A converter high level reference voltage range		3.5		V_{DD}	V
V_{refL}	D-A converter low level reference voltage range		0		1.5	V
V_{AO}	D-A converter output voltage range	$I_{AO} = \pm 500\mu A$	0.1		$V_{CC}-0.1$	V
		$I_{AO} = \pm 1mA$	0.2		$V_{CC}-0.2$	
I_{AO}	Buffer amplifier output current range				± 2.5	mA
DNL	Differential nonlinearity	Guaranteed monotonic	-1.0		1.0	LSB
NL	Nonrinality		-1.5		1.5	LSB
EZ	Zero code error	$V_{refU}=4.79V$	-2		2	LSB
EF	Full scale error	$V_{refL}=0.95V$ without load	-2		2	LSB
E_o	Gain error		-3		3	%
SR	Output slew rate			0.2		V/ μs

TIMING CHART (MODEL)



Input data is carried out LD signal Low besides CLK signal positive edge.
CLK,LD is keep generally High level.

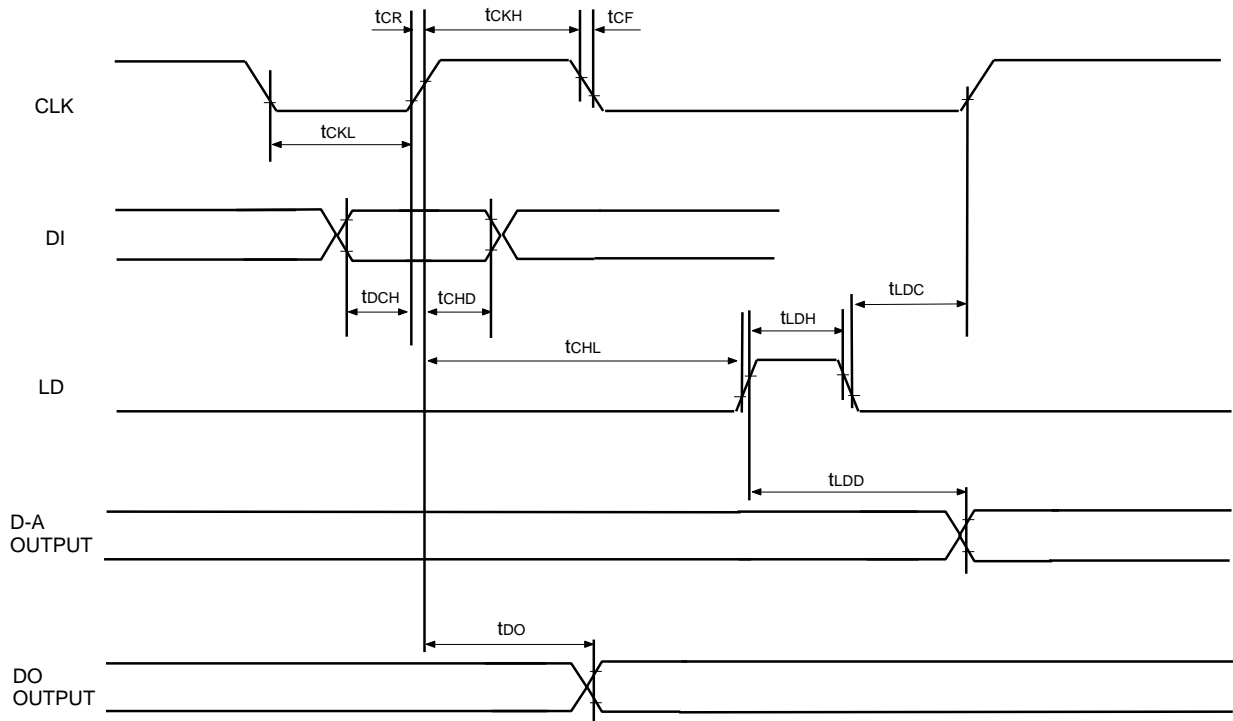
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AC CHARACTERISTICS (Ta=-20~85°C, V_{cc}=13V, V_{DD}=V_{refU}=5V, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
t _{CKL}	Clock "L" pulse width		200			ns
t _{CKH}	Clock "H" pulse width		200			ns
t _{CR}	Clock rise time				200	ns
t _{CF}	Clock fall time				200	ns
t _{DCH}	Data set up time		60			ns
t _{CHD}	Data hold time		100			ns
t _{CHL}	LD setup time		200			ns
t _{LDC}	LD hold time		100			ns
t _{LDH}	LD "H" pulse width		100			ns
t _{DO}	Data output delay time	CL=100pF	70		350	ns
t _{LDD}	D-A output setting time	Without load			300	μs

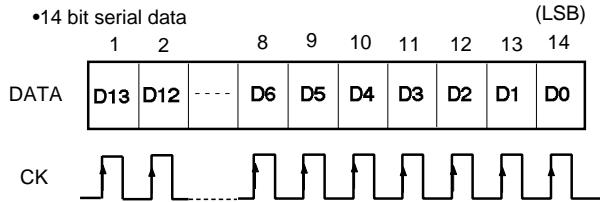
TIMING CHART



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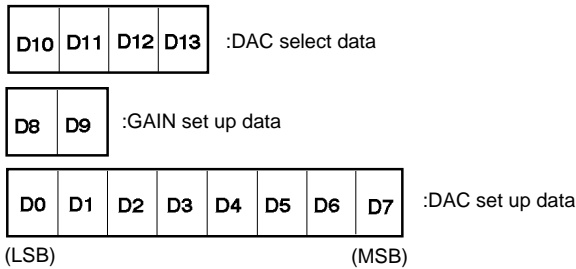
DIGITAL FORMAT



•DAC select data

D10	D11	D12	D13	DAC selection
0	0	0	0	Don't care
0	0	0	1	Ao1 selection
0	0	1	0	Ao2 selection
0	0	1	1	Ao3 selection
0	1	0	0	Ao4 selection
0	1	0	1	Ao5 selection
0	1	1	0	Ao6 selection
0	1	1	1	Ao7 selection
1	0	0	0	Ao8 selection
1	0	0	1	Ao9 selection
1	0	1	0	Ao10 selection
1	0	1	1	Ao11 selection
1	1	0	0	Ao12 selection
1	1	0	1	Don't care
1	1	1	0	Don't care
1	1	1	1	Don't care

•Data assignment



•GAIN set up data

D8	D9	K	DAC output range (VrefU=5V,VrefL=0V)
0	0	1	0~5V
1	0	1.6	0~8V
0	1	1.8	0~9V
1	1	2.4	0~12V

•DAC set up data

(LSB)							(MSB)	DAC voltage
D0	D2	D3	D4	D5	D6	D7		
0	0	0	0	0	0	0	$1/256 \cdot (V_{refU} - V_{refL}) \cdot K + V_{refL}$	
1	0	0	0	0	0	0	$2/256 \cdot (V_{refU} - V_{refL}) \cdot K + V_{refL}$	
0	0	0	0	0	0	0	$3/256 \cdot (V_{refU} - V_{refL}) \cdot K + V_{refL}$	
1	0	0	0	0	0	0	$4/256 \cdot (V_{refU} - V_{refL}) \cdot K + V_{refL}$	
⋮	⋮	⋮	⋮	⋮	⋮	⋮	⋮	
0	1	1	1	1	1	1	$255/256 \cdot (V_{refU} - V_{refL}) \cdot K + V_{refL}$	
1	1	1	1	1	1	1	$256/256 \cdot (V_{refU} - V_{refL}) \cdot K + V_{refL}$	

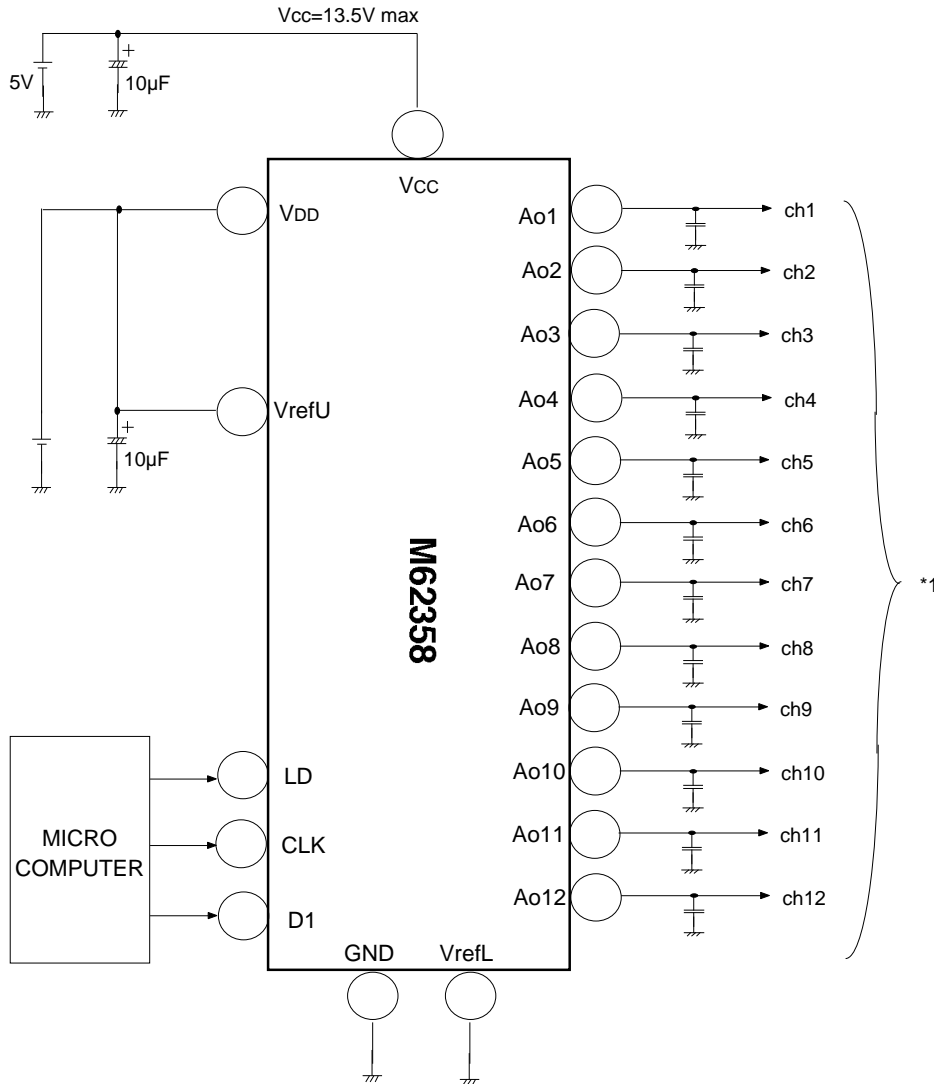
$$A_o = \frac{2^0 \times D_0 + 2^1 \times D_1 + 2^2 \times D_2 + \dots + 2^6 \times D_6 + 2^7 \times D_7 + 1}{256} \cdot (V_{refU} - V_{refL}) \cdot K + V_{refL}$$

K: Amplifiers gain

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APPLICATION CIRCUIT



This IC's output amplifier has an advantage to capacitive load. So it's no problem at device action when connect capacitor among output to GND for every noise eliminate.

*1 If be used in a cathode-ray tube sets and high voltage sets, please connect capacitor among output to GND, about 0.1µF~1µF, because keep off effect of spark and electric discharge etc.